


<b>Search Notes</b>  	<b>Application/Control No.</b>  10757222	<b>Applicant(s)/Patent Under Reexamination</b>  KAEWELL ET AL.
	<b>Examiner</b>  Chen, Junpeng	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
455	574,572	07/18/2007	J.C.
370	311	07/18/2007	J.C.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PG Pub, DERWENT, EPO, JPO and IBM_TDB	07/18/2007	J.C.
Consulted with Quochien Young (455/572,574 and 370/311)	07/18/2007	J.C.
Reconsidered the rejection in view of argument and amendment	5/15/2008	J.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner